Search Notes				

Application No.	Applicant(s)	
10/071,370	BAYNE ET AL.	
Examiner	Art Unit	
Jon M Lockard	1647	

	CEADOUED				
SEARCHED					
Class	Subclass	Date	Examiner		
424	198.1	9/21/2004	JML		
435	69.1	9/21/2004	JML		
	252.3	9/21/2004	JML		
	320.1	9/21/2004	JML		
530	350	9/21/2004	JML		
	399	9/21/2004	JML		
536	23.5	9/21/2004	JML		
	24.31	9/21/2004	JML		
Up deted		2/11/05	JAL		

INTERFERENCE SEARCHED					
Class	Subclass	Date		Examiner	
424	198.1	2/11/05		JML	
435	69.1, 252.3 320.1				
530	350, 399				-
536	23.5, 24.31	2/	11/05	7	ML
Stic Seque	ince search EP: 3, 4	2/	4/05	4٦	12

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Stic Search of Commercial and Patent Databases: See Attached Search Report	9/17/2004	JML
East Search: Text and Inventors Name Search: See attached Search Report.	9/21/2004	JML
PALM: Inventor's Name Search.	9/21/2004	JML
Up date d	2/11/05	JML
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